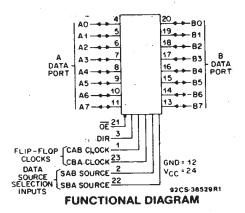
## Technical Data \_\_\_\_\_\_\_ CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648





## **Octal-Bus Transceiver/Registers, 3-State**

CD54/74AC/ACT646 - Non-Inverting CD54/74AC/ACT648 - Inverting

#### **Type Features:**

- Buffered inputs
- Typical propagation delay:
  - 5.3 ns @ Vcc = 5 V, TA = 25° C, CL = 50 pF

The RCA CD54/74AC646 and CD54/74AC648 and the CD54/74ACT646 and CD54/74ACT648 3-state, octal-bus transceiver/registers use the RCA ADVANCED CMOS technology. The CD54/74AC648 and CD54/74ACT648 have inverting outputs. The CD54/74AC646 and CD54/74ACT646 have non-inverting outputs. These devices are bus transceivers with D-type flip-flops which act as internal storage registers on the LOW-to-HIGH transition of either CAB or CBA clock inputs. Output Enable (OE) and Direction (DIR) inputs control the transceiver functions. Data present at the high-impedance output can be stored in either register or both but only one of the two buses can be enabled as outputs at any one time. The Select controls (SAB and SBA) can multiplex stored and transparent (real time) data. The Direction control determines which data bus will receive data when the Output Enable (OE) is LOW. In the highimpedance mode (Output Enable HIGH), A data can be stored in one register and B data can be stored in the other register. The clocks are not gated with the Direction (DIR) and Output Enable (OE) terminals; data at the A or B terminals can be clocked into the storage flip-flops at any time.

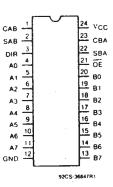
The CD74AC/ACT646 and CD74AC/ACT648 are supplied in 24-lead dual-in-line narrow-body plastic packages (EN suffix) and in 24-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Commercial (0 to  $70^{\circ}$ C); Industrial (-40 to +85°C); and Extended Industrial/Military (-55 o +125°C).

The CD54AC/ACT646 and CD54AC/ACT648, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

#### **Family Features:**

- Exceeds 2-kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST\*/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply
- ± 24-mA output drive current
  Fanout to 15 FAST\* ICs
  Drives 50-ohm transmission lines

\*FAST is a Registered Trademark of Fairchild Semiconductor Corp.



**TERMINAL ASSIGNMENT** 

This data sheet is applicable to the CD74AC646 and CD74ACT646. The CD54AC646, CD54/74AC648, CD54ACT646, and CD54/74ACT648 were not acquired from Harris Semiconductor.

File Number 1970

## CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648

FUNCTION TABLE

		IN	PUTS			DATA	I/O#	OPERATION OR FUNCTION			
ŌĒ	DIR	CAB	CBA	SAB	SBA	A0 THRU A7	B0 THRU B7	646	648		
X	X	 X	· x	X X	X X	Input Not specified	Not specified Input	Store A, B unspecified Store B, A unspecified	Store A, B unspecified Store B, A unspecified		
H H	X X	⊥/¯ HorL	_/_ H or L	X · X	- X X	Input	Input	Store A and B Data Isolation, hold storage	Store A and B Data Isolation, hold storage		
L	L	X X	X H or L	X X	L H	Output	Input	Real-Time B Data to A Bus Stored B Data to A Bus	Real-Time B Data to A Bus Stored B Data to A Bus		
L	H H	X Hor L	X X	L H	X X	Input	Output	Real-Time A Data to B Bus Stored A Data to B Bus	Real-Time A Data to B Bus Stored A Data to B Bus		

#The data output functions may be enabled or disabled by various signals at the OE and DIR inputs. Data input functions are always enabled, i.e., data at the bus pins will be stored on every low-to-high transition on the clock inputs.

To prevent excess currents in the High-Z modes, all I/O terminals should be terminated with 10 k $\Omega$  resistors.

#### MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE (V <sub>cc</sub> ) DC INPUT DIODE CURRENT, I <sub>IK</sub> (for V <sub>1</sub> $<$ -0.5 V or V <sub>1</sub> $>$ V <sub>cc</sub> + 0.5 V) DC OUTPUT DIODE CURRENT, I <sub>ok</sub> (for V <sub>0</sub> $<$ -0.5 V or V <sub>0</sub> $>$ V <sub>cc</sub> + 0.5 V)	±20 mA ±50 mA
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, $I_0$ (for $V_0 > -0.5$ V or $V_0$	
DC Vcc or GROUND CURRENT (lcc or Igno)	±100 mA*
POWER DISSIPATION PER PACKAGE (PD):	
For $T_A = -55$ to $\pm 100^{\circ}$ C (PACKAGE TYPE E)	
For T <sub>A</sub> = +100 to +125°C (PACKAGE TYPE E)	Derate Linearly at 8 mW/°C to 300 mW
For $T_A = -55$ to $+70^{\circ}$ C (PACKAGE TYPE M)	
For $T_A = +70$ to $+125^{\circ}C$ (PACKAGE TYPE M)	. Derate Linearly at 6 mW/°C to 70 mW
OPERATING-TEMPERATURE RANGE (T <sub>A</sub> )	
	65 to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	
At distance 1/16 $\pm$ 1/32 in. (1.59 $\pm$ 0.79 mm) from case for 10 s maximum	+265°C
Unit inserted into PC board min. thickness 1/16 in. (1.59 mm) with solder contactin	ng lead tips only +300°C
*For up to 4 outputs per device; add $\pm$ 25 mA for each additional output.	

#### **RECOMMENDED OPERATING CONDITIONS:**

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

000000000000000000000000000000000000000	LIN		
CHARACTERISTICS	MIN.	MAX.	
Supply-Voltage Range, Vcc*:			
(For $T_A = Full Package-Temperature Range)$			
AC Types	1.5	5.5	V
ACT Types	4.5	5.5	V V
DC Input or Output Voltage, Vi, Vo	0	Vcc	V
Operating Temperature, T <sub>A</sub>	-55	+125	°C
Input Rise and Fall Slew Rate, dt/dv		1	
at 1.5 V to 3 V (AC Types)	0	50	ns/V
at 3.6 V to 5.5 V (AC Types)	0	20	ns/V
at 4.5 V to 5.5 V (ACT Types)	0	10	ns/V

\*Unless otherwise specified, all voltages are referenced to ground.

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# Technical Data CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648

STATIC ELECTRICAL CHARACTERISTICS: AC Series

					AMBIENT	ТЕМРЕ	RATURE	(T <sub>A</sub> ) - ° (	>	UNITS	
CHARACTERIST	ICS	TEST CON	DITIONS	V <sub>cc</sub>	+;	25	-40 te	o +85	-55 to +125		
		V, (V)	l <sub>o</sub> (mA)	(V)	MIN.	MAX.	MIN.	MAX:	MIN.	MAX.	• <b>v</b>
High-Level Input Voltage	Vin			1.5 3 5.5	1.2 2.1 3.85	-	- 2.1	1   -	1.2 2.1 3.85	-	
Low-Level Input Voltage	ViL			1.5 3 5.5	-	0.3 0.9 1.65		0.3 0.9 1.65		0.3 0.9 1.65	v
High-Level Output			-0.05	1.5	1.4	- 1	1.4		1.4		
Voltage	Vон	VIH	-0.05	3	2.9		2.9	_	2.9	—	
		or	-0.05	4.5	4.4	-	4.4	·	4.4		
		ViL	-4	3	2.58		2.48		2.4		V
			-24	4.5	3.94	-	3.8		3.7		
		(	-75	5.5	<u></u>		3.85	_		·	
		#, * {	-50	5.5	—	—			3.85		
Low-Level Output			0.05	1.5	—	0.1	·	0.1		0.1	1
Voltage	ر Vol	ViH	0.05	3	—	0.1		0.1		0.1	
		or	0.05	4.5		0.1		0.1		0.1	
		V <sub>IL</sub>	12	3	_	0.36		0.44	<u> </u>	0.5	V
			24	4.5		0.36	—	0.44	-	0.5	
		#, <b>★</b> {	75	5.5	_	—		1.65	-		
		<i>"</i> , " {	50	5.5		—	-	<u> </u>		1.65	
Input Leakage Current	ł,	V <sub>cc</sub> or GND		5.5		±0.1	-	±1	_	±1	μA
3-State Leakage Current	loz	VIH Or VIL Vo= Vcc Or GND		5.5		±0.5		±5	_	±10	μΑ
Quiescent Supply Current, MSI	lcc	V <sub>cc</sub> or GND	0	5.5	_	8	-	80	-	160	μA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. \*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

#### \_\_\_\_ Technical Data

# CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648

#### STATIC ELECTRICAL CHARACTERISTICS: ACT Series

						AMBIEN	Т ТЕМРЕ	RATURE	E (T <sub>A</sub> ) - ° (	C	UNITS
CHARACTERIST	ICS	TEST CON	DITIONS	V <sub>cc</sub>	+:	25	-40 t	o +85	-55 to	o +125	
		V <sub>i</sub> (V)	l <sub>o</sub> (mA)	(V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input Voltage	Vie			4.5 to 5.5	2		2	_	2		v
Low-Level Input Voltage	VIL			4.5 to 5.5		0.8	-	0.8		0.8	V
High-Level Output		V <sub>IH</sub>	-0.05	4.5	4.4	<u> </u>	4.4	-	4.4	-	
Voltage	V <sub>он</sub>	or Vi∟	-24	4.5	3.94		3.8	—	3.7	—	]
		#. * {	-75	5.5		—	3.85	-		_	] V
		<u>"·</u> )	-50	5.5					3.85		]
Low-Level Output		ViH	0.05	4.5		0.1	-	0.1	_	.0.1	
Voltage	Vol	or ViL	24	4.5		0.36		0.44	_	0.5	l v
		#, * {	• 75	5.5	_	_	—	1.65	, —	_	1
		"' `` · <b>∖</b>	50	5.5	_	—				1.65	1
Input Leakage Current	li.	V <sub>cc</sub> or GND		5.5	_	±0.1		±1	_	±1	μA
3-State Leakage Current	łoz	V <sub>IH</sub> or V <sub>IL</sub> Vo= Vcc or GND		5.5		±0.5		±5		±10	μΑ
Quiescent Supply Current, MSI	lcc	V <sub>cc</sub> or GND	0	5.5	_	8		80		160	μA
Additional Quiescent Current per Input P TTL Inputs High 1 Unit Load		V <sub>cc</sub> -2.1		4.5 to 5.5	_	2.4	_	2.8	_	3	mA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. \*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C. 75 ohms at +125°C.

INPUT	UNIT LOAD*
CAB, CBA	1.25
SAB, SBA	1.2
DIR	0.67
ŌĒ	1.17
An, Bn	0.4

#### ACT INPUT LOADING TABLE

\*Unit load is  $\Delta I_{CC}$  limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

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## Technical Data \_\_\_\_\_\_ CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648

PREREQUISITE FOR SWITCHING: AC Series

			AMBI	ENT TEMPE	RATURE (1	Γ <sub>A</sub> ) - °C		
CHARACTERISTICS	SYMBOL	V <sub>cc</sub> (V)	-40 t	o +85	-55 to	UNITS		
		(*)	MIN.	MAX.	MIN.	MAX.	]	
Max. Frequency	fmax	1.5 3.3* 5†	11 101 143		10 89 125		MHz	
Setup Time Data to Clock	tsu	1.5 3.3 5	27 3.1 2.2		31 3.5 2.5		ns	
Hold Time Data to Clock	tH	1.5 3.3 5	2 2 2	-	2 2 2		ns	
Clock Pulse Width	tw	1.5 3.3 5	44 4.9 3.5	_	50 5.6 4		ns	

\*3.3 V: min. is @ 3 V

†5 V: min is @ 4.5 V

SWITCHING CHARACTERISTICS: AC Series; t,, tr = 3 ns, CL = 50 pF

and the second s			AMBIE	ENT TEMPE	RATURE (T	) - °C	
0110040750107100	SYMBOL	Vcc		o +85		+125	
CHARACTERISTICS	STMOOL	(V)	MIN.	MAX.	MIN.	MAX.	
Propagation Delays:		·····				100	
Store A Data to B Bus	Тесн	1.5	-	154	-	169	
Store B Data to A Bus	Тень	3.3*	4.8	17.1	4.7	18.9	ns
646	UPHL	5†	3.5	12.3	3.4	13.5	
Store A Data to B Bus		1.5	—	154	—	169	
Store B Data to A Bus	t <sub>РLН</sub>	3.3	4.8	17.1	4.7	18.9	ns
648	t <sub>PHL</sub>	5	3.5	12.3	3.4	13.5	
A Data to B Bus		1.5		125	-	138	
B Data to A Bus	t <sub>PLH</sub>	3.3	4	14	3.9	15.4	ns
646	tрнс	5	2.8	10	2.8	11	
Ā Data to B Bus		1.5		125	—	138	-
B Data to A Bus	tецн	3.3	4	14	3.9	15.4	ns
648	t <sub>PHL</sub>	5	2.8	10	2.8	11	
Select to Data		1.5		136	_	150	
646	t <sub>PLH</sub>	3.3	4.3	15.3	4.2	16.8	ns
040	t <sub>PHL</sub>	5	3.1	10.9	3	12	
Select to Data		1.5	<u>+</u>	136		150	
648	tеьн	3.3	4.3	15.3	4.2	16.8	ns
048	tень	5	3.1	10.9	3	12	
3-State Enabling/	tezi			154		169	1
Disabling Time	tezh	1.5	-	18.4	5.1	20.2	ns
Bus to Output or	telz	3.3	5.2 3.5	12.3	3.4	13.5	113
Register to Output	tенz	5	3.5	12.5	3.4	10.0	
Power Dissipation Capacitance	CPD§		150	Тур.	150	Тур.	pF
	он				A		1
During Switching of	Vону						
Other Outputs (Output	See	5	1	4 Typ.	@ 25° C		
Under Test Not	Fig. 1						
Switching)	J						
During Switching of	VOLP						
Other Outputs (Output	See	5		1 Typ.	@ 25° C		V
Under Test Not	Fig. 1						
Switching)	-		1				
Input Capacitance	C <sub>1</sub>		-	10	-	10	pF
3-State Output Capacitance	Co	_		15	T —	15	pF

\*3.3 V: min. is @ 3.6 V

max. is @ 3 V

t5 V: min. is @ 5.5 V max. is @ 4.5 V  $C_{PD}$  is used to determine the dynamic power consumption, per package.  $P_D = V_{CC}^2 C_{PD} f_i + \Sigma (V_{CC}^2 C_L f_o)$  where  $f_i$  = input frequency

 $f_o = output frequency$ 

CL = output load capacitance

V<sub>cc</sub> = supply voltage.

#### \_ Technical Data

## CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648

#### **PREREQUISITE FOR SWITCHING: ACT Series**

		AMBI					
SYMBOL		-40 1	o +85	-55 to	UNITS		
· · · ·	(•)	MIN.	MAX.	MIN.	MAX.	1	
fmax	5*	125	<u> </u>	110		MHz	
tsu	. 5	2.2	_	2.5		ns	
t <sub>H</sub>	5	2		· 2	_	ns	
tw	5	3.9	_	4.5	_	ns	
	fmax tsu t <sub>H</sub>	fmax     5*       tsu     5       t <sub>H</sub> 5	SYMBOL     V <sub>CC</sub> (V)     -40 t MIN.       fmax     5°     125       tsu     5     2.2       tH     5     2	SYMBOL     V <sub>cc</sub> (V)     -40 to +85       fmax     5*     125        tsu     5     2.2        tH     5     2	SYMBOL $V_{cc}$ (V)     -40 to +85     -55 to -55 to MIN. $f_{max}$ 5°     125     —     110 $t_{su}$ 5     2.2     —     2.5 $t_{H}$ 5     2     —     2	fmax     5*     125     MIN.     MAX.     MIN.     MAX. $f_{max}$ 5*     125     —     110     — $t_{SU}$ 5     2.2     —     2.5     — $t_H$ 5     2     —     2     —	

\*5 V: min. is @ 4.5 V

#### SWITCHING CHARACTERISTICS: ACT Series; t, tr = 3 ns, CL = 50 pF

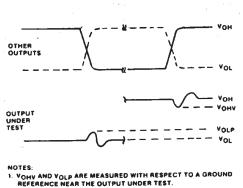
	· · ·		AMB					
CHARACTERISTICS	SYMBOL	V <sub>cc</sub>	-40	to +85	-55 t	o +125		
		(Ÿ)	MIN.	MIN. MAX.		MAX.		
Propagation Delays: Store A Data to B Bus Store B Data to A Bus 646	tрін tрні	5*	4	14.1	3.9	15.5	ns	
Store Ā Data to B Bus Store B Data to A Bus 648	t <sub>есн</sub> t <sub>енс</sub>	5	4	14.1	3.9	15.5	ns	
A Data to B Bus B Data to A Bus 646	telн tehl	5	3.2	11.4	3.1	12.5	ns	
A Data to B Bus B Data to A Bus 648	tесн tень	5	3.2	11.4	3.1	→ 12.5	ns	
Select to Data 646	tецн тенц	5	3.7	13.2	3.6	14.5	ns	
Select to Data 648	tрін Трні	5	4	14.1	3.9	15.5	ns	
3-State Enabling/ Disabling Time Bus to Output or Register to Output	tezi tezi telz telz	5	4	14.1	3.9	15.5	ns	
Power Dissipation Capacitance	Cpd§	_	150	Тур.	150	Тур.	pF	
Min. (Valley) N During Switching of Other Outputs (Output Under Test Not Switching)	Ион Voнv See Fig. 1	5	4 Typ. @ 25°C				v	
Max. (Peak) During Switching of Other Outputs (Output Under Test Not Switching)	Vol P See Fig. 1	5	1 Тур. @ 25°С				v	
Input Capacitance	Cı		-	10		10	pF	
3-State Output Capacitance	Co	_		15		15	рF	

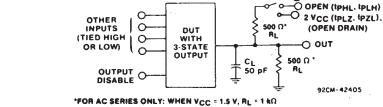
15 V: min. is @ 5.5 V max. is @ 4.5 V §CPD is used to determine the dynamic power consumption, per package.  $P_D = C_{PD}V_{cc}^2 f_i + \Sigma (C_L V_{cc}^2 f_o) + V_{cc} \Delta I_{cc}$  where  $f_i = input frequency$ 

## **Technical Data** CD54/74AC646, CD54/74AC648 CD54/74ACT646, CD54/74ACT648

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PARAMETER MEASUREMENT INFORMATION





OUTPUTS

tei 2

TPHZ

t<sub>r</sub> = 3 ns

OUTPUT: LOW

OUTPUT: HIGH TO OFF TO HIGH

OUTPUT

DISABLE

Fig. 2 - Three-state propagation delay waveforms and test circuit.

te 13 na

tp71

- tPZH

OUTPUTS

INPUT LEVEL 90 %

٧s

VOH (≠VCC)

GND

0.2 VCC VOL (# GND)

٧s

0.8 VCC

92CM-42405

٧s

OUTPUTS ENABLED O GND (IPHZ. IPZH)

1,=3.08 - t, = 3ns INPUT 90% ٧e DATA A(B) - 10% GND ٧o 8(A) AC/ACT 648 † PLH 1 PHE <sup>1</sup>PHL PLH --- V e 8 (A) VO AC/ACT 646 9205-42618

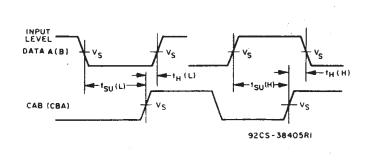


Fig. 4 - Data setup and hold times.

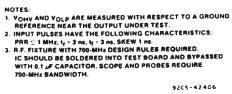
OUTPUT 8 500 Ω DUT C<sub>1</sub> OUTPUT 50 pF LOAD FOR AC SERIES ONLY: WHEN  $V_{CC} = 1.5 V, R_L = 1 k\Omega$ 

Fig. 3 - Propagation delay times.

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	CD54/74AC	CD54/74ACT		
Input Level	Vcc	3 V		
Input Switching Voltage, Vs	0.5 V <sub>cc</sub>	1.5 V		
Output Switching Voltage, Vs	0.5 V <sub>cc</sub>	0.5 V <sub>cc</sub>		

Fig. 5 - Test circuit.





9205-42406



29-May-2015

## PACKAGING INFORMATION

Orderable Device	Status	Package Type	-	Pins	-		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD74AC646M	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC646M	Samples
CD74AC646M96	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC646M	Samples
CD74AC646MG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC646M	Samples
CD74ACT646EN	LIFEBUY	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT646EN	
CD74ACT646M	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT646M	Samples
CD74ACT646M96	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT646M	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



## PACKAGE OPTION ADDENDUM

29-May-2015

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nomi	nal											
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC646M96	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
CD74ACT646M96	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

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## PACKAGE MATERIALS INFORMATION

26-Jan-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC646M96	SOIC	DW	24	2000	367.0	367.0	45.0
CD74ACT646M96	SOIC	DW	24	2000	367.0	367.0	45.0

NT (R-PDIP-T\*\*) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



All integrations are in minimeters. Dimensioning and toil
B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



## LAND PATTERN DATA



NOTES:

A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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